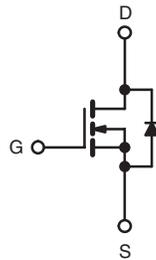
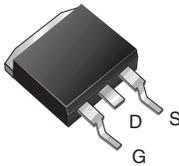


## Power MOSFET

| PRODUCT SUMMARY           |                        |      |
|---------------------------|------------------------|------|
| $V_{DS}$ (V)              | 200                    |      |
| $R_{DS(on)}$ ( $\Omega$ ) | $V_{GS} = 10\text{ V}$ | 0.80 |
| $Q_g$ (Max.) (nC)         | 16                     |      |
| $Q_{gs}$ (nC)             | 2.9                    |      |
| $Q_{gd}$ (nC)             | 9.6                    |      |
| Configuration             | Single                 |      |

**SMD-220**


N-Channel MOSFET

### FEATURES

- Surface Mount
- Available in Tape and Reel
- Dynamic  $dV/dt$  Rating
- Repetitive Avalanche Rated
- Logic Level Gate Drive
- $R_{DS(on)}$  Specified at  $V_{GS} = 4\text{ V}$  and  $5\text{ V}$
- Fast Switching
- Lead (Pb)-free Available


 Available  
**RoHS\***  
 COMPLIANT

### DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SMD-220 is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The SMD-220 is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application.

### ORDERING INFORMATION

|                              |                          |  |
|------------------------------|--------------------------|--|
| Package                      | SMD-220                  | SMD-220  |
| Lead (Pb)-free IRL620STRLPbF | IRL530SPbF<br>SiH530S-E3 | IRL620STRLPbF <sup>a</sup><br>SiHL620STL-E3 <sup>a</sup> |
| SnPb                         | IRL530STRR<br>SiH530STR  | -<br>-   |

**Note**

a. See device orientation.

### ABSOLUTE MAXIMUM RATINGS $T_C = 25\text{ }^\circ\text{C}$ , unless otherwise noted

| PARAMETER  | SYMBOL         | LIMIT                             | UNIT                |   |
|--|----------------|-----------------------------------|---------------------|---|
| Drain-Source Voltage                               | $V_{DS}$       | 200                               | V                   |   |
| Gate-Source Voltage                                | $V_{GS}$       | $\pm 10$                          |                     |   |
| Continuous Drain Current                           | $I_D$          | $V_{GS}$ at 5 V                   | 5.2                 | A |
|  |                | $T_C = 100\text{ }^\circ\text{C}$ | 3.3                 |   |
| Pulsed Drain Current <sup>a</sup>                  | $I_{DM}$       | 21                                | W/ $^\circ\text{C}$ |   |
| Linear Derating Factor                             |                | 0.40                              |                     |   |
| Linear Derating Factor (PCB Mount) <sup>e</sup>    |                | 0.025                             |                     |   |
| Single Pulse Avalanche Energy <sup>b</sup>         | $E_{AS}$       | 125                               | mJ                  |   |
| Repetitive Avalanche Current <sup>a</sup>          | $I_{AR}$       | 5.2                               | A                   |   |
| Repetitive Avalanche Energy <sup>a</sup>           | $E_{AR}$       | 5.0                               | mJ                  |   |
| Maximum Power Dissipation                          | $P_D$          | $T_C = 25\text{ }^\circ\text{C}$  | 50                  | W |
|  |                | $T_A = 25\text{ }^\circ\text{C}$  | 3.1                 |   |
| Maximum Power Dissipation (PCB Mount) <sup>e</sup> |                |                                   |                     |   |
| Peak Diode Recovery $dV/dt^c$                      | $dV/dt$        | 5.0                               | V/ns                |   |
| Operating Junction and Storage Temperature Range   | $T_J, T_{stg}$ | - 55 to + 150                     | $^\circ\text{C}$    |   |
| Soldering Recommendations (Peak Temperature)       | for 10 s       | 300 <sup>d</sup>                  |                     |   |

**Notes**

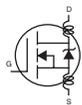
- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- $V_{DD} = 50\text{ V}$ , starting  $T_J = 25\text{ }^\circ\text{C}$ ,  $L = 6.9\text{ mH}$ ,  $R_G = 25\text{ }\Omega$ ,  $I_{AS} = 5.2\text{ A}$  (see fig. 12).
- $I_{SD} \leq 5.2\text{ A}$ ,  $dI/dt \leq 95\text{ A}/\mu\text{s}$ ,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 150\text{ }^\circ\text{C}$ .
- 1.6 mm from case.
- When mounted on 1" square PCB (FR-4 or G-10 material).

\* Pb containing terminations are not RoHS compliant, exemptions may apply

| THERMAL RESISTANCE RATINGS                           |            |      |      |      |
|--|------------|------|------|------|
| PARAMETER  | SYMBOL     | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient                          | $R_{thJA}$ | -    | 62   | °C/W |
| Maximum Junction-to-Ambient (PCB mount) <sup>a</sup> | $R_{thJA}$ | -    | 40   |      |
| Maximum Junction-to-Case (Drain)                     | $R_{thJC}$ | -    | 2.5  |      |

### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

| SPECIFICATIONS $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted |                     |   |  |      |      |           |               |
|--|---------------------|---|--|------|------|-----------|---------------|
| PARAMETER  | SYMBOL              | TEST CONDITIONS   |  | MIN. | TYP. | MAX.      | UNIT          |
| <b>Static</b>  |                     |   |  |      |      |           |               |
| Drain-Source Breakdown Voltage   | $V_{DS}$            | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$   |  | 200  | -    | -         | V             |
| $V_{DS}$ Temperature Coefficient   | $\Delta V_{DS}/T_J$ | Reference to $25\text{ }^\circ\text{C}$ , $I_D = 1\text{ mA}$   |  | -    | 0.27 | -         | V/°C          |
| Gate-Source Threshold Voltage  | $V_{GS(th)}$        | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$   |  | 1.0  | -    | 2.0       | V             |
| Gate-Source Leakage  | $I_{GSS}$           | $V_{GS} = \pm 10\text{ V}$  |  | -    | -    | $\pm 100$ | nA            |
| Zero Gate Voltage Drain Current  | $I_{DSS}$           | $V_{DS} = 200\text{ V}, V_{GS} = 0\text{ V}$  |  | -    | -    | 25        | $\mu\text{A}$ |
|  |                     | $V_{DS} = 320\text{ V}, V_{GS} = 0\text{ V}, T_J = 125\text{ }^\circ\text{C}$   |  | -    | -    | 250       |               |
| Drain-Source On-State Resistance   | $R_{DS(on)}$        | $V_{GS} = 10.0\text{ V}$  | $I_D = 3.1\text{ A}^b$   | -    | -    | 0.80      | $\Omega$      |
|  |                     | $V_{GS} = 4.0\text{ V}$   | $I_D = 2.6\text{ A}^b$   | -    | -    | 1.0       |               |
| Forward Transconductance   | $g_{fs}$            | $V_{DS} = 50\text{ V}, I_D = 3.1\text{ A}^b$  |  | 1.2  | -    | -         | S             |
| <b>Dynamic</b>   |                     |   |  |      |      |           |               |
| Input Capacitance  | $C_{iss}$           | $V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1.0\text{ MHz}$ , see fig. 5  |  | -    | 360  | -         | pF            |
| Output Capacitance   | $C_{oss}$           |   |  | -    | 91   | -         |               |
| Reverse Transfer Capacitance   | $C_{rss}$           |   |  | -    | 27   | -         |               |
| Total Gate Charge  | $Q_g$               | $V_{GS} = 5.0\text{ V}$   | $I_D = 5.2\text{ A}, V_{DS} = 160\text{ V}$ , see fig. 6 and 13 <sup>b</sup> | -    | -    | 16        | nC            |
| Gate-Source Charge   | $Q_{gs}$            |   |  | -    | -    | 2.9       |               |
| Gate-Drain Charge  | $Q_{gd}$            |   |  | -    | -    | 9.6       |               |
| Turn-On Delay Time   | $t_{d(on)}$         | $V_{DD} = 100\text{ V}, I_D = 5.2\text{ A}, R_G = 9.0\text{ }\Omega, R_D = 20\text{ }\Omega$ , see fig. 10 <sup>b</sup>                                 |  | -    | 4.2  | -         | ns            |
| Rise Time  | $t_r$               |   |  | -    | 31   | -         |               |
| Turn-Off Delay Time  | $t_{d(off)}$        |   |  | -    | 18   | -         |               |
| Fall Time  | $t_f$               |   |  | -    | 17   | -         |               |
| Internal Drain Inductance  | $L_D$               | Between lead, 6 mm (0.25") from package and center of die contact  |  | -    | 4.5  | -         | nH            |
| Internal Source Inductance   | $L_S$               |   |  | -    | 7.5  | -         |               |
| <b>Drain-Source Body Diode Characteristics</b>                           |                     |   |  |      |      |           |               |
| Continuous Source-Drain Diode Current                                    | $I_S$               | MOSFET symbol showing the integral reverse p-n junction diode      |  | -    | -    | 5.2       | A             |
| Pulsed Diode Forward Current <sup>a</sup>                                | $I_{SM}$            |   |  | -    | -    | 21        |               |
| Body Diode Voltage   | $V_{SD}$            | $T_J = 25\text{ }^\circ\text{C}, I_S = 5.2\text{ A}, V_{GS} = 0\text{ V}^b$   |  | -    | -    | 1.8       | V             |
| Body Diode Reverse Recovery Time   | $t_{rr}$            | $T_J = 25\text{ }^\circ\text{C}, I_F = 5.2\text{ A}, di/dt = 100\text{ A}/\mu\text{s}^b$  |  | -    | 180  | 270       | ns            |
| Body Diode Reverse Recovery Charge                                       | $Q_{rr}$            |   |  | -    | 1.1  | 1.7       | $\mu\text{C}$ |
| Forward Turn-On Time   | $t_{on}$            | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )   |  |      |      |           |               |

### Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- Pulse width  $\leq 300\text{ }\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

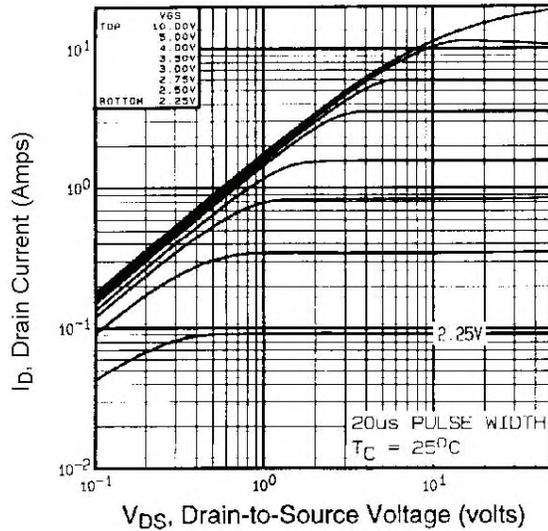


Fig. 1 - Typical Output Characteristics,  $T_C = 25\text{ }^\circ\text{C}$

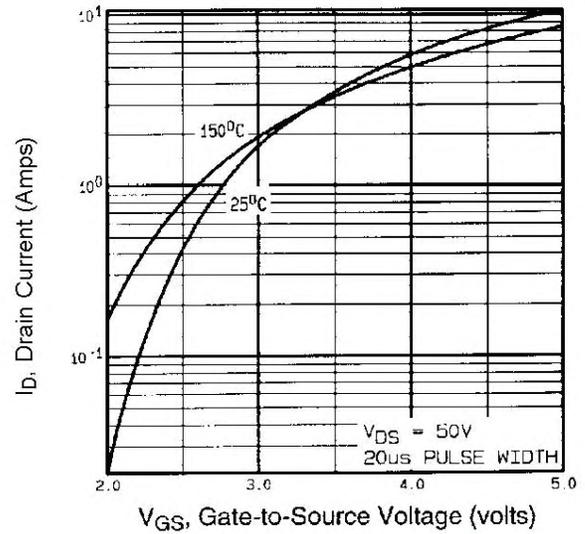


Fig. 3 - Typical Transfer Characteristics

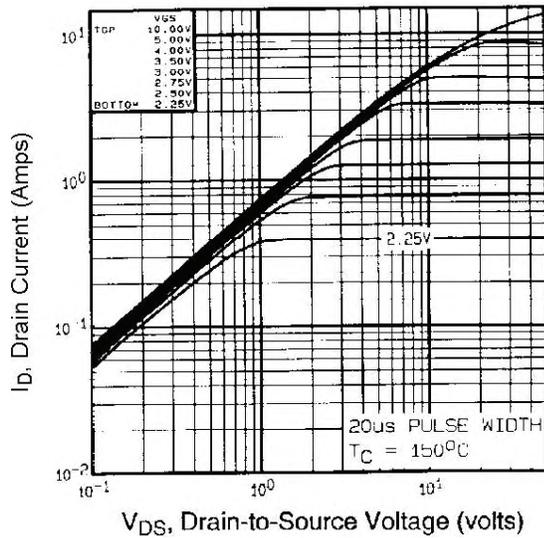


Fig. 2 - Typical Output Characteristics,  $T_C = 150\text{ }^\circ\text{C}$

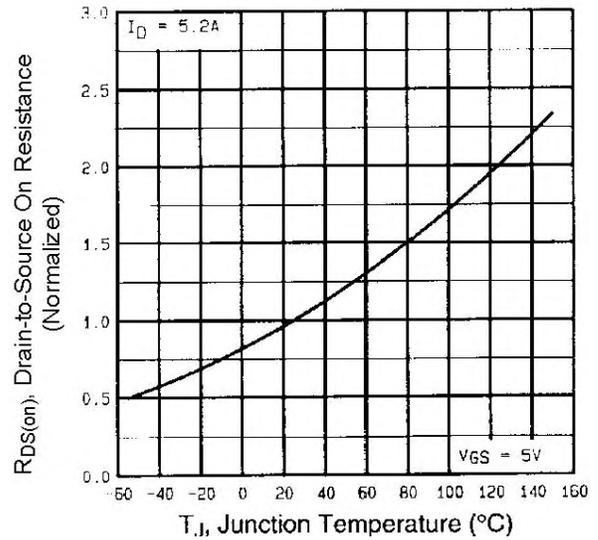


Fig. 4 - Normalized On-Resistance vs. Temperature

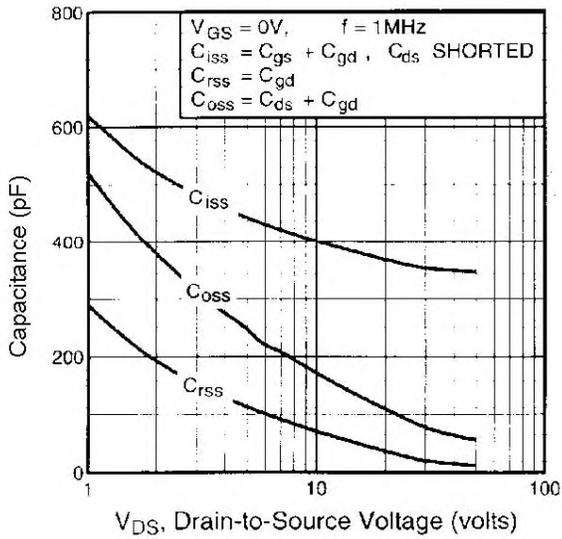


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

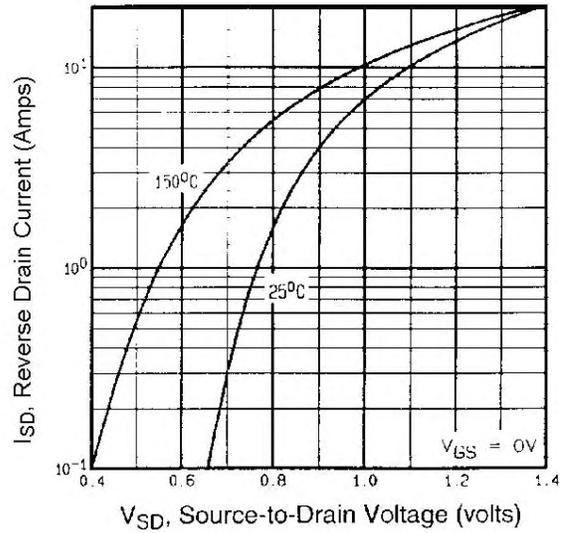


Fig. 7 - Typical Source-Drain Diode Forward Voltage

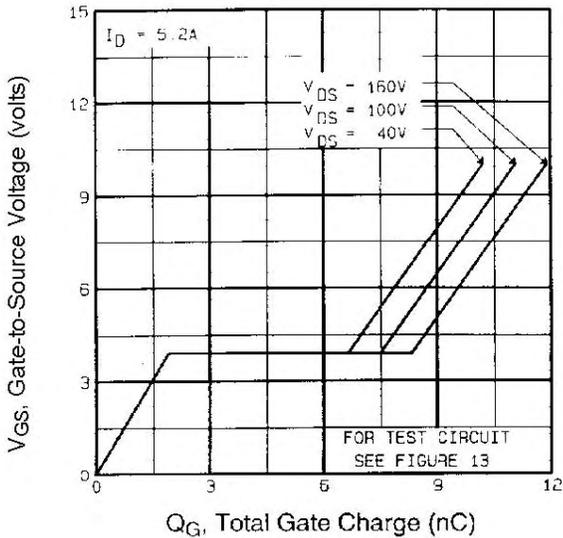


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

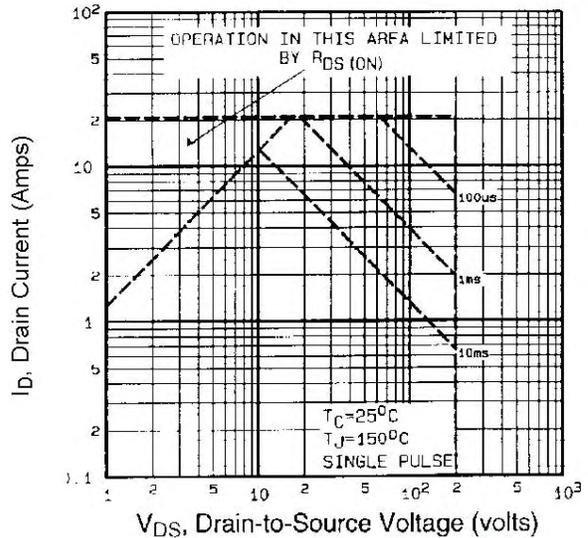


Fig. 8 - Maximum Safe Operating Area

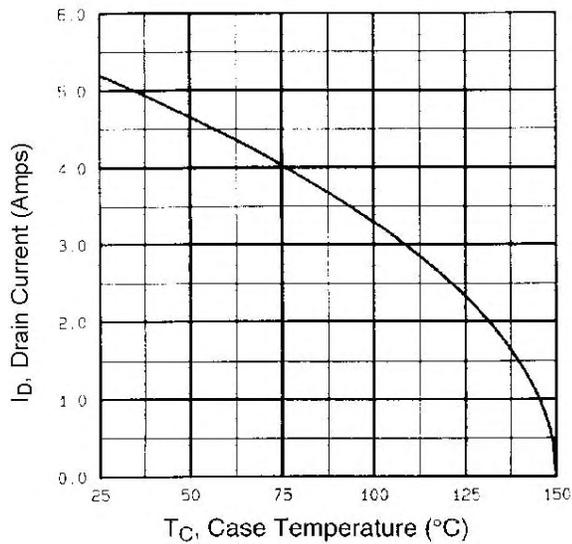


Fig. 9 - Maximum Drain Current vs. Case Temperature

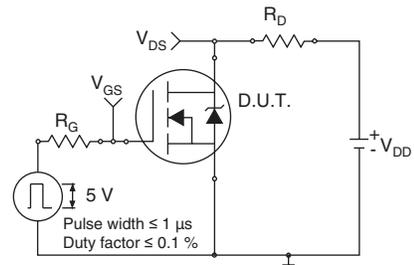


Fig. 10a - Switching Time Test Circuit

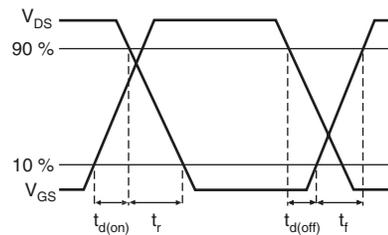


Fig. 10b - Switching Time Waveforms

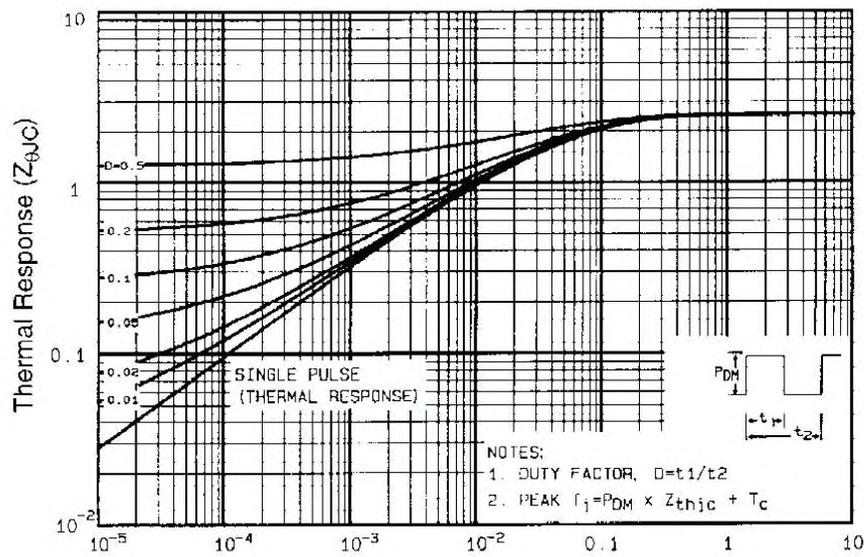


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

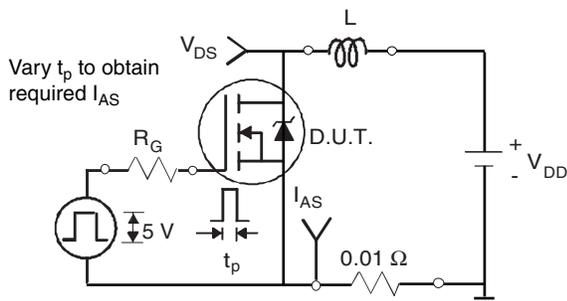


Fig. 12a - Unclamped Inductive Test Circuit

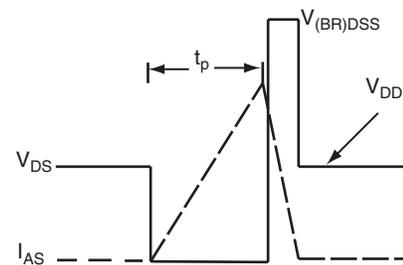


Fig. 12b - Unclamped Inductive Waveforms

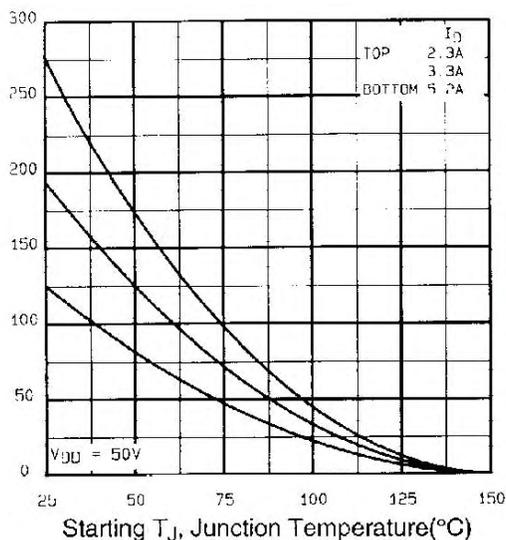


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

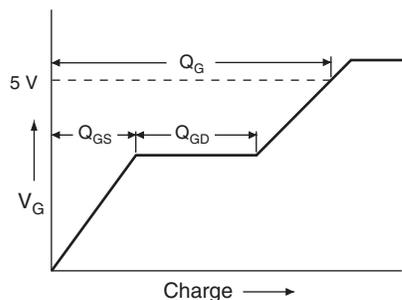


Fig. 13a - Basic Gate Charge Waveform

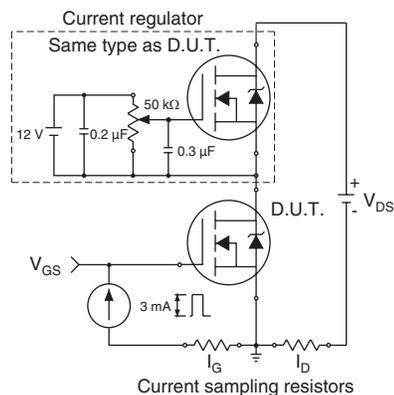
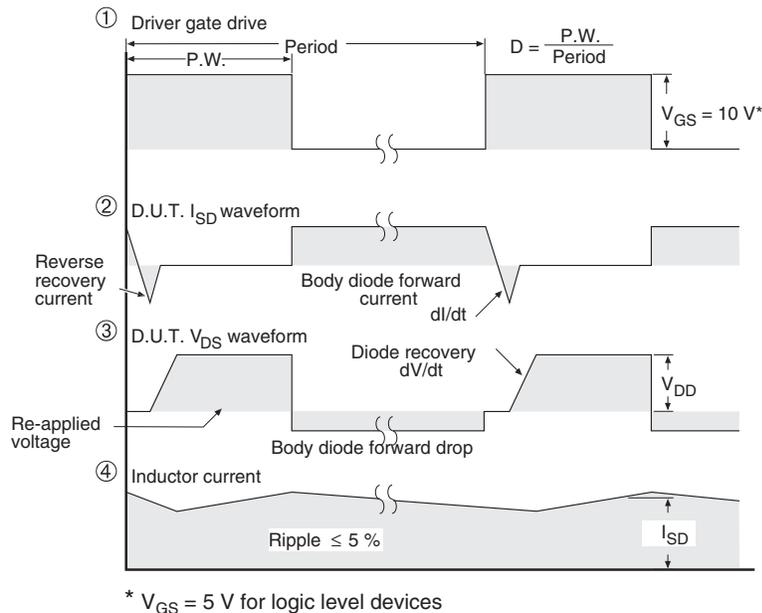
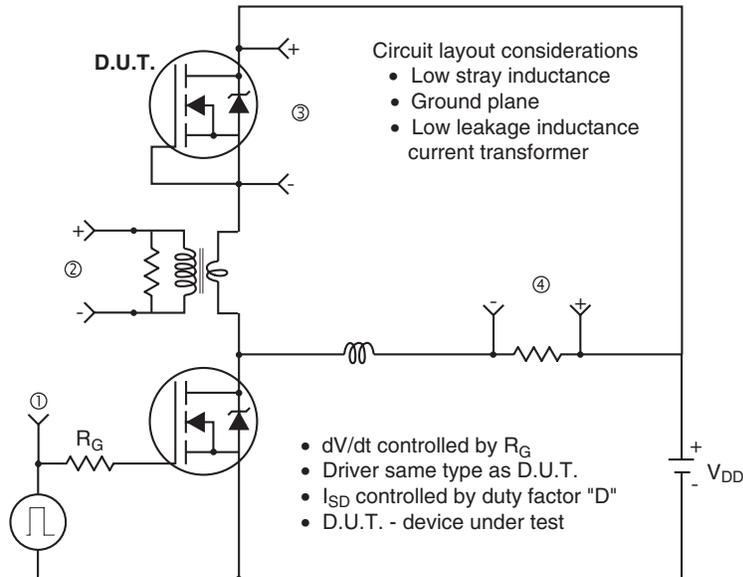


Fig. 13b - Gate Charge Test Circuit

## Peak Diode Recovery $dV/dt$ Test Circuit



**Fig. 14 - For N-Channel**

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